Ferroelectricity Newsletter

A quarterly update on what's happening in the field of ferroelectricity

Volume 13, Numbers 3&4

Summer/Fall 2005

YEAR-END REPORT OF NEWS IN THE FIELD

The **17th International Symposium on Integrated Ferroelectrics** (ISIF 2005) took place from 17-20 April 2005 in Shanghai, China. The field of ferroelectric/piezoelectric/high-K dielectric/phase-change materials is growing rapidly because of the potential application in MEMS technologies and the development of new generations of nonvolatile memory devices. Please check the index of the papers, starting on page 2 of this issue, to see that the presentations reflect the maturity and the acceptance of the technology.

The other set of papers indexed in this issue is from the **NATO Advanced Research Workshop on dimensionality effects and non-linearity in ferroics**, held on 19-22 October 2004 in Lviv, Ukraine. (Please see pages 24 ff.)

The **18th International Symposium on Integrated Ferroelectrics** (ISIF 2006) will be held on 23 - 27 April 2006 in Honolulu, Hawaii. You will find information, including a detailed description on the technical program, beginning on page 27.

The other announcement about upcoming meetings deals with the **8th European Conference on Applications of Polar Dielectrics** (ECAPD 8) to take place from 5 - 8 September 2006 in Metz, France. Topics of this conference include materials research, application oriented studies of physical properties of dielectrics, and device research, such as piezoelectric transducers, smart sensors and actuators, pyroelectric detectors, electro-optic modulators, spatial light modulators and displays, 2D and 3D optical storage devices, ferroelectric memories, and microelectromechanical devices.

As of this moment, future funding for the *Ferroelectricity Newsletter* is uncertain. This issue will therefore be the last we publish as hard copy. We will try, however, to keep our website open. This allows you continued access to all archived material. Since the future of our Ferroelectricity Newsletter is not yet defined, we encourage all of you to email us your thoughts and suggestions. In turn, we keep you posted on any new development.

We thank all of our readers for your loyal support these past 13 years, as well as the Naval Postgraduate School and the Office of Naval Research for making it possible to produce this newsletter.

Our very best wishes for your continuing successful professional career.

Rudolf Panholzer Editor-in-Chief

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Please visit our Web site: http://www.sp.nps.navy.mil/projects/ ferro/ferro.html

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PLENARY SESSION

Studying ferroelectrics with synchroton radiation *S. Baik*

High density ferroelectric nonvolatile memories: Opportunities, progress and challenges

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Challenges for high density 3D FeRAM

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Novel BC plug technology for highly reliable mass productive 0.18µm 1T1C COB embedded FRAM

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FRAM reliability issues and improvement for advanced FRAM *T. Eshita*

Effects of novel electrodes for thin Pb(Zr,Ti)O3 films by controlling PZT interface

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ISIF 2005 PAPERS

Integration processes and properties of semiconductive oxide memory transistor

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High density and low power nonvolatile FeRAM with non-driven plate, selected driven bit-line and complimentary shielded bit-line scheme

Yasuo Murakuki

Influence of the mechanical stress on the stability of encapsulated electrodes used in 3D ferroelectric capacitor configurations

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Electrical property of MOCVD-PZT thin film capacitor patterned by dry etching

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Polarization instability of Pt/PZT/Pt ferroelectric capacitor invoked by voltage cycling

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Study on the structure and dielectric properties of Ba(Sn_XTi_{1-X})O₃ thin films grown by a sol-gel process *Song Sannian, Zhai Jiwei, Yao Xi, and Zhang Liangying*

The microstructure characteristics and dielectric behaviors of the compositionally graded Ba(Ti,Sn)O₃ thin films Jiwei Zhai, Xi Yao, T.F. Hung, Zhengkui Xu, and Haydn Chen

Improvement of electrical properties of sol-gel derived (Ba_{0.8}Sr_{0.2})TiO₃ thin films by inserting seed layer *Zhi Fu, Aiying Wu, and P.M. Vilarinho*

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structure using Ga₂O₃ films prepared by plasma enhanced atomic layer deposition

Sang-A Lee, Se-Young Jeong, Jae-Yeol Hwang, Chae-Ryong Cho, and Won-Jae Lee

Effects of manganese addition on pyroelectric properties of (Bi_{0.5-x}Na_{0.5}TiO₃)_{0.94}(BaTiO₃)_{0.06} ceramics

J. Abe, M. Kobune, T. Nshimura, and T. Yazawa

Electro-optic effect in ferroelectric Na_{0.5}K_{0.5}NbO₃ thin films on oxide substrates

Mats Blomqvist, Sergey Khartsev, and Alex Grishin

Physical properties of hydrothermally grown PZT epitaxial film Kyoon Choi, Chang-Jung Kim, Ho-Yong Lee, and Byung-Ik Kim

Barium strontium zirconate titanate (BSZT) thin films for optical waveguide applications S.H. Choy, D.Y. Wang, J.Y. Dai,

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Piezoelectric and dielectric properties of transparent PZN-PLZT ceramics

Guochu Deng, Aili Ding, Zeng Xia, and Tao Liu

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H. Harada, I. Kanno, T. Suzuki, H. Kotera, K. Wasa, T. Matsunaga, H. Okino, and T. Yamamoto

Crystallization and photoluminescence characteristics of ZnO thin films deposited by RF magnetron sputtering

P.T. Hsieh, C.M. Wang, Y.C.Chen, Y.N. Guo, and C.C. Hu

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Development of reactive ion etching for ferroelectric MEMS

Y. Kokaze, M. Ueda, M. Endo, and K. Suu

Preparation and piezoelectric properties of sol-gel derived niobium-doped lead zirconate titanate films for MEMS applications

K.W. Kwok, K.P. Kwok, R.C.W. Tsang, H.L.W. Chan, and C.L. Choy

Effect of deposition conditions on the ferroelectric properties of barium sodium niobate thin films deposited by ion beam sputtering

Hee Young Lee, Junhui Lou, Jeong-Joo Kim, and Sang-Hee Cho

Effects of seed layer thickness and deposition atmosphere on crystallization and ferroelectric properties of SBN thin films

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Investigation on etch characteristics of GeSbTe thin films for phase-change memory

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Effects of PZT buffer layers on PZFNT ferroelectric thin films Jiagen Peng, Chaowei Zhong, Shuren Zhang, Mingxia Sun, Yue Pang, and Wanli Zhang

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Phase transitions of poly(vinylidene flouride) under electric fields

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Dielectric response of PZN-PZT ceramics with lanthanum doping Xia Zeng, Aili Ding, Xiyun He, Tao Liu, Guochu Deng, and Xinsen Zheng

Non-columnar grained microstructure in ferroelectric PZT thin films via chemical solution deposition - A possible way of lifting-off thin films for MEMS applications

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Fabrication of PZT thin films with TiOB_XB buffer layers by RF magnetron sputtering

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An active pyroelectric sensor with differential ferroelectric cells

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Epitaxial growth and structural characterization of transparent conducting ZnO:Al thin film deposited on GaN substrate by RF magnetron sputtering

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Screen printed PZT thick films using chemical solution modified by hybrid deposition techniques for MEMS devices

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Microstructure characterization of ferroelectric single crystal substrate surface for SAW devices of property degradation

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The analysis of cymbal transducer's effective piezoelectric coefficients

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Integration of dielectric Ba_{0.6}Sr_{0.4}(Ti_{0.94}Al_{0.06})O₃ thin films with silicon substrates via Ir/MgO bi-layer buffers

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A bi-stable micro-machined piezoelectric transducer for mechanical to electrical energy transformation

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A novel miniature optical switch with double vertical micromirrors driven by piezoelectric cantilever

Huajun Fang, Litian Liu,Ningxin Zhang, Xiaoming Wu, and Tianling Ren

Design and optimization of micro scanner driven by folded piezoelectric unimorph actuators using PZT films

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Fabrication of piezoelectric 1-3 composite for forward-looking ultrasonic probes

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Micromachined polymer piezoelectric membrane acoustic sensor *T.Y. Lam, H.L.W. Chan, and C.L.*

Substrate and structure dependencies of the effective piezoelectric coefficient (d_{33,eff}) of PZT thin films: Simulations and measurements

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The thin film thickness dependence of ferroelectric infrared detector properties

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Micromachined polymer piezoelectric membrane acoustic

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Design of a novel piezoelectric acoustic sensor using surface micromachining

Yi Yang, Tian-Ling Ren, and Li-Tian Liu

The effect of DC bias on the resonant frequency of PZT microresonators

Junjun Wang, Jia Zhu, Yiping Huang, and Thomas Gessner

Uniformity improvement of PZT based ultrasonic transducer

Yi-Ping Zhu, Tian-Ling Ren, Yi Yang, Xiao-Ming Wu, Ning-Xin Zhang, Li-Tian Liu, and Zhi-Jian Li

The effect of geometry on the displacement amplification and resonance characteristics of the cymbal transducers

Cheng-Liang Sun, S.S. Guo, W.P. Li, Z.B. Xing, G.C. Liu, and X.-Z. Zhao

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All-epitaxial multi-layered (Bi,La)₄Ti₃O₁₂/Pb(Zr_{0.4}Ti_{0.6})O₃ ferroelectric thin films on SrTiO₃ substrates grown by pulsed laser deposition

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Piezoelectric properties of compositionally graded epitaxial Pb(Zr,Ti)O₃ thin films prepared by multi-RF-sputtering

I. Kanno, K. Nakano, T. Suzuki, H. Kotera, and K. Wasa

Finite size effect of the dielectric property in BaTiO₃/SrTiO₃ superlattice, BaTiO₃ and SrTiO₃ single oxide layer

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Impedance spectroscopy and time dependent relaxation behavior of PMN-PZT actuators joined by ceramic slurry

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Preparation and study on compositionally graded Pb(Zr,Ti)O₃ ferroelectric thin films

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Growth of LaMnO₃/SrMnO₃/ NdMnO₃ artificial superlattices Phan Bach Thang, Kwang-Ryul Lee, Jin Woo Kim, and Jaichan Lee

Evidence of additional transition in ferroelectromagnet
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Ferroelectric properties of BiFeO₃-Sr_{0.8}Bi_{2.2}Ta₂O₉ solid solutions

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Observations of giant ferroelectric polarization in the multiferroic BiFeO₃ thin films

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Ferroelectric properties of multiferroic BiFeO₃-Pb(Zr,Ti)O₃ thin films for high density FeRAM devices

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Microwave dielectric properties for (Pb,La)(Zr,Ti)O₃ thin films on MgO (001) substrate grown by chemical solution deposition

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Characteristic of (100)-textured Pb(Sr_xTi_{1-x})O₃ thin film used for DRAM and tunable device application

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Microwave tunable units based on (Ba,Sr)TiO₃ ceramics with various additives

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Microwave phase shifter based on piezo-controlled layered dielectric structure

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A study of ferroelectric phase shifter with photonic-bandgap (PBG) structure

Young-Tae Kim, Han-Cheol Ryu, Seung-Eon Moon, Min-Hwan Kwak, Su-Jae Lee, and Kwang-Young Kang Stress controlled ferroelectric (Ba_{0.5}Sr_{0.5})TiO₃ thin films prepared on Gd₂O₃/MgO(001) by a pulsed laser deposition

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Structural and microwave properties of ferroelectric (Ba_XSr_{1-X})TiO₃ films prepared by a sol-gel method Sang Su Kim, Mun Heum Park, Min Ju Gang, Jun-Ki Chung, Jong Kuk Kim, Won-Jeong Kim, In-Sung Kim, Jae-Sung Song, Seung Eon Moon, Min-Hwan Kwak, Su-Jae Lee, and Kwang Yong Kang

Barium zirconate titanate-based inorganic dielectric material with high permittivity as a lead-free insulator for semiconductor applications

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A Ka-band ferroelectric phase shifter using modified coplanar waveguide

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Electronic structure of bismuth titanate-base films Bi_{4-X}R_XTi₃O₁₂ dependence on substitution atom *Yunseok Kim, Yang Soo Kim, SungKwan Kim, Young-Ah Jeon, Kwangsoo No*

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Morphotropic phase boundary movement in epitaxial PZT thin films - 2D capacitor size effect *Kilho Lee and Sunggi Baik*

Nano-sized domain formation of PbZrO₃/PbTiO₃ artificial superlattices by scanning probe microscopy Jaichan Lee, Taekjib Choi, Bongki Lee, and Hyunjung Shin

The performance of Ge₂Sb₂Te₅ material and nonvolatile phase-change-memory device

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Controllable charge density in the Si nanocrystals nonvolatile memory Tiezheng Lu, Jun Shen, Margit Zacharias, Marin Alexe, and Ulrich Gösele

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Role of nano-scale nonpolar inclusions in polarization reversal in relaxor PZT ceramics

V. Ya. Shur, E.L Rumyantsev, G.G. Lomakin, O.V. Yakutova, E.V. Nikolaeva, D.V. Pelegov, A. Sternberg, and M. Kosec

Phase stability after an electric-field poling in high-strain ferroelectric Pb(Mg_{1/3}Nb_{2/3})_{1-x}Ti_xO₃ (PMNTx%) crystals *Chi-Shun Tu, F.-T. Wang, R.R. Chien, and V.H. Schmidt*

Electrical characteristics of Aunanocrystals embedded in metaloxide-semiconductor structures

Chan-Chen Wang, Jiun-Yi Tseng,
and Tai-Bor Wu

Structures and properties of barium strontium titanate nanoparticles synthesized by a hydrothermal method

Ji Liu. Di Wu, Yu Deng, Aidong Li, and Naiben Ming

Studies on the characterization of the SnO₂ nanowires growth Ming-Ju Yang and Sheng-Yuan Chu

Heteroepitaxial growth of the ferroelectric Pb(Zr_{0.2}Ti_{0.8})O₃ thin films on SrRuO₃/SrTiO₃ structures for nano-data storage

Woo-Sung Lee, Kyoung-Chan Ahn, Nak-Jin Seong, and Soon-Gil Yoon

Finite size effects on the structural and physical properties in BaTiO₃ and SrTiO₃ nanocrystals

Jian Yu and Junhao Chu

Local elasticity response in ferroelectric crystals studied by AFMbased novel probe techniques H.F. Yu, H.R. Zeng, R.Q. Chu, G.R. Li, H.S. Luo, and Q.R. Yin

Controlled 1dimensional nanostructures of PbTiO3: From nanoparticles to nanotubes Lili Zhao, Martin Steinhart, Jian Yu, Jun Shen, Eckhard Pippel, Petra Göring, Martin Alexe, and Ulrich Gösele

Lithium niobate and doped lithium niobate nanoshell tubes by hightemperature melts wetting *Lili zhao, Martin Steinhart, Jun* Shen, Jian Yu, Petra Göring, Herbert Hofmeister, Marin Alexe, and Ulrich Gösele

Phase transition in Pb(Mg_{1/3}Nb_{2/3})_{0.67}Ti_{0.33}O₃ single crystal

Peng Bao, Feng Yan, Xiaomei Lu, Huimin Shen, Jingsong Zhu, and Yening Wang

SPM imaging of domains in periodically poled LiTaO3 crystals

Yi Kan, Xiaomei Lu, Peng Bao,
and Jingsong Zhu

Self-assembly of bismuth oxide nanostructure using the metal-organic decomposition method *J. Ma, Y. Kan, X.M. Lu, and J.S. Zhu*

Ferroelectric nanotubes as [3D] DRAM and FRAM self-trenched capacitors

F.D. Morrison, M. Mikaye, V.M. Kugler, and J.F. Scott

Nanoscale piezoelectric and elastic phenomena of ferroelectric domain H.F. Yu, R.Q. Chu, G.R. Li, H.S. Luo, and Q.R. Yin

The preceding papers were delivered at the

17TH INTERNATIONAL SYMPOSIUM ON INTEGRATED FERROELECTRICS (ISIF 2005) In addition, five tutorial sessions were held:

- Fundamentals of FeRAM circuit design architecture, device modeling Shoichi Matsui (Fujitsu)
- High density FeRAM process integration *Dirk Wouters (IMEC)*
- Materials for MEMS and ferroelectric memories, ferroelectric nanostructures, and multi-ferroics Marin Alexe (Max Planck)
- The measurement methodology of ferro-component and testing technique of FeRAM as well as ferroelectric device physics

 Jason Chen (Symetrix Corporation)
- Ferroelectric and electrode fabrication for 3D structures MOCVD Hiroshi Funakubo (Tokyo Institute of Technology)

ARW PAPERS

DIMENSIONALITY EFFECTS AND NON-LINEARITY IN FERROICS

This NATO Advanced Research Workshop was held in Lviv, Ukraine, on 19 - 22 October 2004. The proceedings were published in two volumes of the international journal **FERROELECTRICS** (Volumes 316 and 317, 2005), guest edited by André Perrin (France) and Ihor Stasyuk (Ukraine). In their editorial they say, "We also considered it (the workshop) as a continuation of a series of open Ukrainian-French meetings on ferroelectrics physics; two previous such meetings were held in Kyiv, Ukraine, in 2000 and in Dinard, France, in 2002. We are very pleased to say that above 80 participants from nine countries attended this Workshop."

Special attention was paid to ferroic materials with low dimensionality (thin films and nanosize objects), relaxors, spin glasses, as well as nonlinear phenomena in ferroelectric systems, related to domain walls motion, external field influences, disorder, and others.

Eight invited speaker lectures and 30 contributed oral presentations were delivered. A poster session was held with 48 presentations given. The latest achievements in technology for the film growth by pulsed laser deposition permit a control of the thin film/nanosize system fabrication on anatomic scale and thus obtain objects with the properties set on demand. The problems related to an improvement of the quantitative characteristics of the low-dimensional ferroic materials, in particular, growth control methods, purity of the materials, decrease of their dielectric losses, polarization fatigue, and ageing of their relevant physical characteristics were of substantial interest during the Workshop. So were principal questions for theory and technology, such as size dependencies of the ferroelectric characteristics of nano objects/films and fundamental limitations for their geometrical dimensions, such as critical thickness for thin film ferroelectricity. Unusual effects were reported, e.g., observation of the ferroelectric properties of nanocrystals and thin film heterostructures identical to those of bulk crystals. Theoretical approaches to description of thin film behavior, taking into account depolarization fields, substrate misfit strains surface tension, and gradients of volume free energy density were also presented.

Extensive discussion focused on the properties of ferroic materials driven by the domain walls system, manifesting complicated dependences on temperature, time, frequency, and pressure. Attention was paid to a complex domain wall dynamics with the pinning effect at impurities chaotic switching phenomena and stochastic resonance in ferroelectrics, field-induced reconstruction of nano-scale domain structures in ceramics, and ferroelastic twinning.

Finally, the following topics were under consideration: disordered relaxor ferroelectrics, polycrystalline, ceramic (with nanosized grains or dispersed nanosize ferroelectric particles), polymer and glassy materials; nonlinear dielectric, elastic, optical, and piezoelectric properties of ferroelectrics; phase transitions, external pressure and field effects nonlinearities in external fields, and domain phenomena in such systems.

Depolarization field in thin ferroelectric films with account of semiconductor electrodes

M.D. Glinchuk, B.Y. Zaulychny, and V.A. Stephanovich

Ferroelectric thin films for applications in high frequency range

A. Rousseau, M. Guilloux-Viry, V. Bouquet, A. Perrin, G. Tanné, F. Huret, J.F. Seaux, D. Cros, and V. Madrangeas Dimensional effects on ferroelectrics: Ultra-thin single crystals, nanotubes, nano-rods, and nano-ribbons

J.F. Scott

Field induced evolution of nanoscale structures in relaxor PLZT ceramics

V.Ya. Shur, E.L. Rumyantsev, G.G. Lomakin, O.V. Yakutova, D.V. Pelegov, A. Sternberg, and M. Kosec Dielectric and pyroelectric response of BaTiO₃-PVDF nanocomposites B. Hilczer, J. Kulek, M. Polomska, M.D. Glinchuk, A.V. Ragulya, and A. Pietraszko

Size effects in BaTiO3 nanopowders studied by EPR and NMR

F. Frdem. R. Roettcher. H.- I.

E. Erdem, R. Boettcher, H.-J. Glaesel, E. Hartmann, G. Klotzsche, and D. Michel

Theory of Rochelle salt: Beyond the

ARW PAPERS

Mitsui model

I.V. Stasyuk and O.V. Velychko

Temperature dependence of the nonlinearity coefficient of strontium titanate

J. Dec, W. Kleemann, and M. Itoh

Chaos and stochastic resonance in ferroelectrics—Two effects related to switching

M. Distelhorst

Epitaxial regrowth of ferroelectric thin films on bottom electrodes A. Perrin, A. Rousseau, J.R. Duclère, and M. Guilloux-Viry

Thickness dependence of random field distribution in thin films made of disordered ferroelectrics V.A. Stephanovich, E.V. Kirichenko, J. Drózdz, and H. Drózdz

Effective dielectric function in highpermittivity ceramics and films J. Petzelt and I. Rychetsky

Compositional and pressure effects on the phase transition in ferroelectric NH₄H(ClH₂CCOO)₂

M. Zdanowska-Fraczek, R.

M. Zdanowska-Fraczek, R. Jakubas, and P. Czarnecki

The effect of isotopic and isovalent impurity on low and infra-low frequency dielectric response of the TGS and RS model crystals

A.V. Shilnikov, V.A. Fedorikhin, and N.V. Ratina

Spin models with different types of competing interactions

R.R. Levitskii, S.I. Sorokov, and A.S. Vdovych

EPR of LGO:Cu²⁺ crystals

M.P. Trubitsyn, M.D.

Volnianskii, and A. Yu. Kudzin

Phases coexistence of hydrogenbonded K_{1-X}(NH₄)_XH₂PO₄ crystal Z. Trybula, J. Kaszynski, and H. Maluszynska

Structural studies of relaxor/ferroelectric Pb(Mg_{1/3}Nb_{2/3})O₃/ PbTiO₃ superlattices H. Bouyanfif, N. Lemée, M. El Marssi, F. Le Marrec, B. Dkhil, and M.G. Karkut

Localized polaron type states in ferroelectrics-ferroelastics

M.B. Belonenko and E.V.

Demushkina

Transmission and dispersion of refractive indices in nonlinear optical CsLiB₆O₁₀ single crystals *V.T. Adamiv, Ya.V. Burak, M.M. Romanyuk, G.M. Romanyuk, and I.M. Teslyuk*

Band energy structure and optical properties of Ag₂CdI₄ superionic compound

I. Bolesta, V. Savchyn, and S. Velgosh

Deposition of PZT thin films on polymer substrate by means of low pressure plasma jet system

A. Deyneka, Z. Hubicka, L. Jastrabik, M. Cada, P. Virostko, J. Olejnicek, G. Suchaneck, and G. Gerlach

Randon field based model for calculation of the properties of relaxor ferroelectric thin films

E.A. Eliseev and M.D. Glinchuk

Critical behaviour of Sn₂P₂S₆

ferroelectric crystals under high pressure

P.P. Guranich, A.G. Slivka, V.S. Shusta, O.I. Gerzanich, and I.Yu. Kuritsa

Ba_XSr_{1-X}TiO₃ thin films deposited by RF hollow cathode plasma jet technique

Z. Hubicka, J. Olejnícek, M. Cada, P. Virostko, H. Sichová, A. Deyneka, and Z. Czapla

Phase transitions in Ag₂CdI₄: Electrical studies *Ivan Karbovnyk*

On the plasma transitions in ferroelectric-antiferroelectric mixed systems

N.A. Korynevskii and V.B. Solovyan

Critical behaviour of 3D systems in the external field

M.P. Kozlovskii

Piezoelectric resonance and sound attenuation in Rochelle salt

A.P. Moina, R.R. Levitskii, and I.R. Zachek

Theoretical description of coercive field decrease in ferroelectricssemiconductors with charged defects

Anna N. Morozovska

Analytic method of calculating thermodynamic functions for Isinglike system in an external field

I.V. Pylyuk, M.P. Koslovskii, and O.O. Prytula

Lead-free relaxor ferroelectric ceramics in NaNbO₃-Sr_{0.5}NbO₃-LiNbO₃ solid solution system *S.I. Raevskaya, J.-L.*

ARW PAPERS

Dellis, L.A. Reznichenko, S.A. Prosandeev, I.P. Raevski, S.O. Lisitsina, and L. Jastrabik

Linear versus nonlinear field dependence of dielectric stiffness in relaxors

I.P. Raevski, S.A. Prosandeev, A.S. Emelyanov, Eugene V. Colla, J.-L. Dellis, M. El Marssi, and L. Jastrabik

Inversion of the sign of birefringence and its application in thermometry

M.O. Romanyuk and M.M. Romanyuk

The baric changes of the electron polarisability of LiRbSO₄, LiKSO₄ and (NH₄)₂BeF₄ crystals *V.Yo. Stadnyk and M.O. Romanyuk*

Lattice dynamics simulation of CsH₂PO₄ crystal *Ya. Shchur* Linear thermal expansion of ferroelectric deuterated triglycine sulphate

I.S. Girnyk, O.S. Kushnir, and R.Y. Shopa

Optical activity of the KDP group crystals

Y. Shopa, L. Lutsiv-Shumskiy, and R. Serkiz

Temperature and pressure effect on the absorption edge in (Sn_{0.95}Zn_{0.05})₂P₂S₆ crystal V.S. Shusta, V.V. Tovt, A.G. Slivka, P.P. Guranich, E.I. Gerzanich, and I.Y. Kuritsa

Pressure effect on Sn₂P₂Se₆ type incommensurate crystals

A.G. Slivka, V.M. Kedyulich, and
E.I. Gerzanich

The refractive properties of uniaxially stressed doped TGS crystals V.Yo. Stadnyk and M.O. Romanyuk

Exact and variational treatment of ferroelectric thin films with different materials of electrodes

V.A. Stephanovich, M.D. Glinchuk, and V.Y. Zaulychny

The effect of axial pressure on domain state and dielectric properties of Na_{0.5}Bi_{0.5}TiO₃ and related materials

J. Suchanicz and T.V. Kruzina

Hydrostatic pressure dependence of T_C for SASD type crystals *I.E. Lipinski, J. Kuriata, and N.A. Korynevskii*

Luminescence of ferroelectric CsPbCl₃ nanocrystals A. Voloshinovskii, S. Myagkota, and R. Levitskii

Ferroelectric thin film self-polarization induced by mismatch effect *M.D. Glinchuk and A.N. Morozovska*

Ferroelectricity Newsletter

including all back issues is available on Internet

http://www.sp.nps.navy.mil/projects/ferro/ferro.html

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18th International Symposium on Integrated Ferroelectrics (ISIF 2006) 23 - 27 April 2006 Honolulu, Hawaii, USA

In 2006, ISIF will return to the United States to be held in Honolulu, Hawaii, on the beautiful beaches of Waikiki. This meeting will be particularly exciting as we have entered a phase in which we are seeing more and more FeRAM devices in production.

As interest in this field continues to grow, it remains the goal of the ISIF organization to uphold its repudation as a premier conference and source for information in the ferroelectric field. To accomplish this goal for ISIF 2006, we are offering the opportunity for select companies to participate in the International Symposium on Integrated Ferroelectrics 2006 as sponsors.

ISIF is offering several benefits to participating sponsors. Your company may elect to provide a \$2,000 or \$3,000 sponsorship or you may choose to sponsor an event such as the Welcome Reception, the Conference Luncheon, or the Banquet Dinner for \$5,000. Please visit our Web site for details.

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- Dr. Orlando Auciello, Argonne National Lab

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Symposium Coordinator:

• Kerry Baugh, University of Colorado at Colorado Springs (kerry@isif.net)

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Technical Program

Plenary Speakers:

- Prof. Dennis Polla (DARPA program manager and University of Minnesota)
 - "Directions for ferroelectric MEMS and NEMS for defense applications"
- Dr. Kinam Kim (President, Samsung Semiconductor Division)
 - "Memory research programs at Samsung"
- Dr. Greg Atwood (Intel)

Session 1: Device Process Integration/Reliability (Ferro-, Piezo-, Pyro-electrics, etc.)

- (a) Circuit Design and Architecture
- (b) Modeling (Spice, etc.)
- (c) Processing and Reliability of FeRAMs, Sensors and Actuators, and Devices for Medical Applications

Session Chairs:

Dr. S.K. Hong (Hynix)

Dr. J.S. Cross (Fujitsu)

Invited Speakers:

- K. Yamakawa (Toshiba), "Key process for high density 0.13um FeRAM and beyond"
- S.-H. Kim (INOSTEK), "The long-term reliability of BFO-PZT ferroelectric thin films for RF-embedded FeRAM devices"
- D. Hadnagy (Consultant), "Intrinsic and extrinsic issues associated with the reliability of FRAM"

Session 2: Alternative Nonvolatile Memory Technologies

- (a) Nonoxide based Phase Change Memory (or PCRAM)
- (b) Oxide based Resistive Probe Storage (or RRAM)
- (c) Magnetic (or MRAM)

Session Chairs:

Prof. B.H. Park (Konkuk University)

Prof. M. Kawasaki (Tohoku University and CERC)

Invited Speakers:

- S.A. Seo (Samsung Advanced Institute of Technology), "Resistance change of NiO for nonvolatile memory application"
- M. Kozicki (Arizona State University), "A review of solid electrolyte memory"
- S. Parkin (IBM), "A storage class memory: The magnetic racetrack"
- I. Meijer (IBM Zürich Research Lab), "A candidate for nonvolatile memory"

Session 3: Integrated FE Liquid Crystals & Organic-FE Structures

Session Chair:

Prof. S. Lagerwall (Chalmers University)

Invited Speakers:

- D. Kruerke (CRLO Displays Limited), "Ferroelectric liquid crystal on silicon microdisplays and their applications"
- M. Wand (LC Vision, Boulder, CO) "Germanium-containing ferroelectric liquid crystals for improved display performance"

Session 4: Integrated Microwave Materials and Devices

Session Chairs:

Prof. G. Subramanyam (University of Dayton)

Prof. S. Baik (Postech)

Invited Speakers:

- R. Biggers (AFRL, USA), "Integrated BST thin films through process-controlled pulsed-laser deposition"
- T.-B. Wu (National Tsingua University, Taiwan), "Interfacial varactor characteristics from interdiffusion in the ferroelectric thin films deposited on high-resistivity Si"

Session 5: High K Films in Packaging, DRAMs, and CMOS

Session Chairs:

Prof. R. Waser (RWTH Aachen)

Prof. P.C. McIntyre (Stanford University)

Invited Speakers:

- P. Majhi (Intel), "A materials perspective of challenges and opportunities for future generation CMOS devices"
- J.D. Baniecki (Fujitsu Laboratories), "High performance barium strontium titanate thin film capacitors for low inductance decoupling applications"
- X. Guo (University of Florida), "Defect chemistry of SrTiO3: From bulk materials to thin films of nanometer thickness"
- S. Stemmer (UC Santa Barbara), "Scanning transmission electron microscopy of high-k gate stacks for CMOS"

Session 6: FeRAM Materials (PZT, SBT, BLT, BiFeO₃, etc.)

- (a) Thin-Film Processing
- (b) Materials Characterization

Session Chairs:

Prof. R. Katiyar (University of Puerto Rico)

Prof. M. Shimizu (University of Hyogo)

Invited Speakers:

- H. Funakubo (Tokyo Institute of Technology), "Development of low voltage-saturated polycrystalline PZT film"
- L. Eng (Dresden University), "Nanoscale electronic and optical properties in ferroic materials"
- Z.G. Liu (Nanjing University), "Dynamic behavior of domain switching and the mechanism of the fatigue phenomenon in SBT and BLT thin films"

Session 7: MEMS, Pyroelectric/IR, Optoelectronic Materials

- (a) Thin-Film Processing
- (b) Materials Characterization

Session Chairs:

Prof. J. Lee (Sungkyunkwan University)

Dr. Q. Zhang (Cranfield University)

Invited Speakers:

- T.S. Kim (KIST, Korea), "MEMS devices using piezoelectric thin and thick films"
- H.M. Jang (POSTECH), "Structure and magnetoelectric (ME) coupling properties of BiFeO₃-based thin films and single crystals"

Session 8: Materials Modeling/Theory

- (a) Domains
- (b) Domain Dynamics in Films

Session Chairs:

Dr. A.K. Tagantsev (Swiss Federal Institute of Technology)

Prof. N. Valanoor (Univeristy of New South Wales, Australia)

Invited speakers:

- I. Lukyanchuk, "Thermodynamic and electrical properties of ferroelectric domains in films"
- S.K. Streiffer (Argonne National Lab), "In-situ synchroton X-ray scattering studies of ferroelectric behavior in epitaxial PZT films"

Session 9: Multi-Ferroic/Magnetoelectric Films

Session Chairs:

Prof. R. Ramesh (University of California at Berkeley)

Prof. M. Okuyama (Osaka University)

Invited Speakers:

- G. Srinivasan (Oakland University), "Ferromagnetic-ferroelectric layered structures for microwave signal processing"
- H. Tabata (Osaka University), "Multi-ferroic relaxors"

Session 10: Ferroelectrics under Restricted Geometries

(e.g., Superlattices, Nanorods, Nanodots, Ultrathin Films/Crystals

Session Chairs:

Dr. M. Alexe (Max Planck Institute)

Prof. J.-M. Triscone (University of Geneva)

Invited Speakers:

- E. Mishina (Montana State), "Ferroelectric dots and two-dimensional nanostructure: From technology and physics to applications"
- H. N. Lee (Oak Ridge National Lab), "Strain and ferroelectricity in artificially designed superlattices and ultrathin PZT films"
- M. Gregg (Queens University, Belfast), "Ferroelectric behavior in free-standing single crystal 'thin films' and 3D nanoshapes made with a focused ion beam microscope"
- M. Dawber (University of Geneva), "Controlling ferroelectricity in PbTiO3/SrTiO3 superlattices"

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8th European Conference on Applications of Polar Dielectrics (ECAPD 8) 5 - 8 September 2006 Metz, France

The conference will be organized by the "Laboratoire Matériaux Optiques, Photonique et Systèmes" (LMOPS) associated with the University of Metz, Supélec, and the Centre National de la Recherche Scientifique (CNRS) with the collaboration of the Ecole Nationale Supérieure d'Arts et Métiers (ENSAM).

Topics

- · Material research
 - Single crystals, thin films, ceramics, polymers, composites and liquid crystals, processing and fabrication technologies
- Application-oriented studies of physical properties of dielectrics

Ferro-, piezo-, and pyroelectric properties, electro-optical and nonlinear optical effects, photorefractivity and photoconductivity, ultrasonics, high Tc superconductivity, ionic conductivity, microstructure related properties, domain engineering

• Device research

Piezoelectric transducers, smart sensors and actuators, pyroelectric detectors, electro-optic modulators, spatial light modulators and displays, 2D and 3D optical storage devices, optical signal processors, optical frequency converters, integrated optical devices, nonlinear photonic bandgaps, periodically poled ferroelectric devices, ferroelectric memories, microelectromechanical systems

Location

The conference will take place at Metz-Technopole. The historical city of Metz in the north-east of France is easily reachable from Paris and Frankfurt (Germany) in about three hours train travel. Luxembourg International Airport with frequent flights to all major European cities is 70 km north of Metz and easily available by public transportation.

Contact

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Chairman ECAPD8 Conference

Laboratoire LMOPS, Supélec

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Summer/Fall 2005

Ferroelectricity Newsletter

CALENDAR OF EVENTS 2006

Apr 23-27 • 18th International Symposium on Integrated Ferroelectrics (ISIF 2006), Honolulu, Hawaii, USA (see p. 27)

Jun 18-22 • Electroceramics X, Toledo, Spain. Contact: http://electro-x.etsit.upm.es

Sep 5-8 • 8th European Conference on Applications of Polar Dielectrics ECAPD 8), Metz, France (see p. 31)